

Replaces March 1998 version, DS4093-2.3

DG648BH45

Gate Turn-off Thyristor

тсм

V

Γ(ΔV

di_Jdt

dV_/dt

DS4093-3.0 January 2000

KEY PARAMETERS

2000A

4500V

745A

1000V/µs

300A/μs

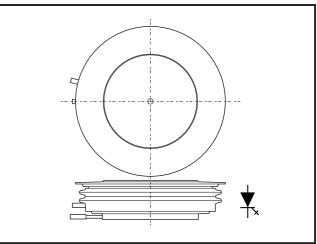
APPLICATIONS

- Variable speed A.C. motor drive inverters (VSD-AC)
- Uninterruptable Power Supplies
- High Voltage Converters
- Choppers
- Welding
- Induction Heating
- DC/DC Converters

FEATURES

- Double Side Cooling
- High Reliability In Service
- High Voltage Capability
- Fault Protection Without Fuses
- High Surge Current Capability

■ Turn-off Capability Allows Reduction In Equipment Size And Weight. Low Noise Emission Reduces Acoustic Cladding Necessary For Environmental Requirements



Outline type code: H. See Package Details for further information.

VOLTAGE RATINGS

Type Number	Repetitive Peak Off-state Voltage V _{DRM} V	Repetitive Peak Reverse Voltage V _{RRM} V	Conditions
DG648BH45	4500	16	$T_{vj} = 125^{\circ}C, I_{DM} = 50mA,$ $I_{RRM} = 50mA$

CURRENT RATINGS

Symbol	Parameter	Conditions	Max.	Units
I _{TCM}	Repetitive peak controllable on-state current	$V_{D} = V_{DRM}, T_{j} = 125^{\circ}C, di_{GQ}/dt = 40A/\mu s, Cs = 2.0\mu F$	2000	А
I _{T(AV)}	Mean on-state current	$T_{HS} = 80^{\circ}C$. Double side cooled. Half sine 50Hz.	745	А
I _{T(RMS)}	RMS on-state current	$T_{_{HS}} = 80^{\circ}$ C. Double side cooled. Half sine 50Hz.	1170	А

SURGE RATINGS

Symbol	Parameter	Conditions	Max.	Units
I _{TSM}	Surge (non-repetitive) on-state current	10ms half sine. T _j = 125°C	16.0	kA
l²t	I ² t for fusing	10ms half sine. T _j =125°C	1.28 x 10 ⁶	A ² s
di _⊤ /dt	Critical rate of rise of on-state current	$V_{\rm D}$ = 4500V, I _T = 2000A, T _j = 125°C, I _{FG} > 30A, Rise time > 1.0µs	300	A/µs
dV _D /dt	Rate of rise of off-state voltage	To 66% V_{DRM} ; $R_{GK} \le 1.5\Omega$, $T_j = 125^{\circ}C$	175	V/µs
		To 66% V _{DRM} ; V _{RG} = -2V, T _j = 125°C	1000	V/µs
L _s	Peak stray inductance in snubber circuit	$I_{T} = 2000A, V_{DM} = 4500V_{1}T_{j} = 125^{\circ}C, di_{GQ}/dt = 40A/\mu s, Cs = 2.0\mu F$	200	nH

GATE RATINGS

Symbol	Parameter	Conditions	Min.	Max.	Units
V _{rgm}	Peak reverse gate voltage	This value maybe exceeded during turn-off	-	16	V
I _{FGM}	Peak forward gate current		20	100	А
P _{FG(AV)}	Average forward gate power		-	15	W
P _{RGM}	Peak reverse gate power		-	19	kW
di _{gq} /dt	Rate of rise of reverse gate current		30	60	A/μs
t _{ON(min)}	Minimum permissable on time		50	-	μs
t _{OFF(min)}	Minimum permissable off time		100	-	μs

THERMAL RATINGS AND MECHANICAL DATA

Symbol	Parameter	Conditions		Min.	Max.	Units
R _{th(j-hs)}	DC thermal resistance - junction to heatsink surface	Double side cooled		-	0.018	°C/W
		Anode side cooled		-	0.03	°C/W
		Cathode side cooled		-	0.045	°C/W
R _{th(c-hs)}	Contact thermal resistance	Clamping force 20.0kN With mounting compound	per contact	-	0.006	°C/W
T _{vj}	Virtual junction temperature			-	125	°C
T _{OP} /T _{stg}	Operating junction/storage temperature range			-40	125	°C
-	Clamping force			18.0	22.0	kN

CHARACTERISTICS

Symbol	Parameter	Conditions	Min.	Max.	Units
$V_{\rm TM}$	On-state voltage	At 2000A peak, $I_{G(ON)} = 7A$ d.c.	-	3.2	V
I _{DM}	Peak off-state current	V _{DRM} = 4500V, V _{RG} = 0V	-	100	mA
I _{RRM}	Peak reverse current	At V _{RRM}	-	50	mA
V _{gt}	Gate trigger voltage	$V_{\rm D} = 24V, I_{\rm T} = 100A, T_{\rm j} = 25^{\circ}{\rm C}$	-	1.0	V
I _{gt}	Gate trigger current	V _D = 24V, I _T = 100A, T _j = 25°C	-	3.0	A
I _{RGM}	Reverse gate cathode current	$V_{RGM} = 16V$, No gate/cathode resistor	-	50	mA
E _{ON}	Turn-on energy	V _D = 3000V	-	3170	mJ
t _d	Delay time	$I_{T} = 2000A, dI_{T}/dt = 300A/\mu s$	-	1.35	μs
t,	Rise time	$I_{FG} = 30A$, rise time < 1.0µs	-	3.2	μs
E	Turn-off energy		-	10000	mJ
t _{gs}	Storage time		-	20.0	μs
t _{gf}	Fall time	I _T = 2000A, V _{DM} = V _{DRM}	-	2.0	μs
t _{gq}	Gate controlled turn-off time	Snubber Cap Cs = 2.0µF,	-	22.0	μs
Q _{GQ}	Turn-off gate charge	$di_{GQ}/dt = 40A/\mu s$	-	6000	μC
Q _{GQT}	Total turn-off gate charge		-	12000	μC
I _{GQM}	Peak reverse gate current		-	690	A

CURVES

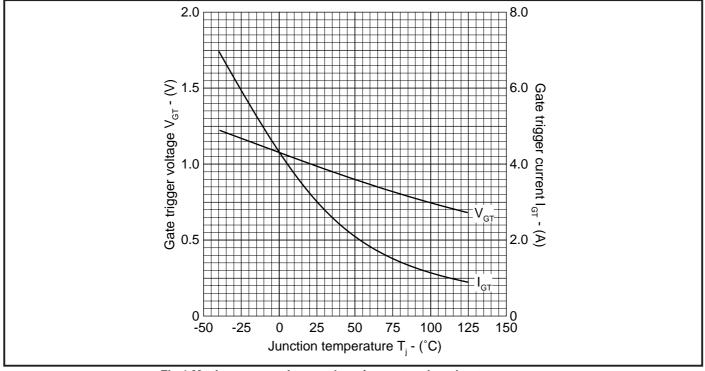


Fig.1 Maximum gate trigger voltage/current vs junction temperature

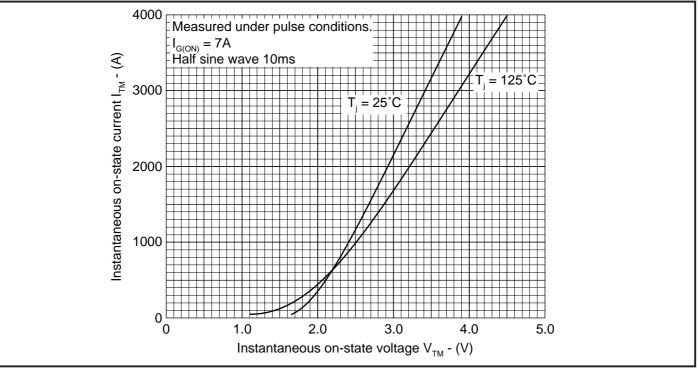
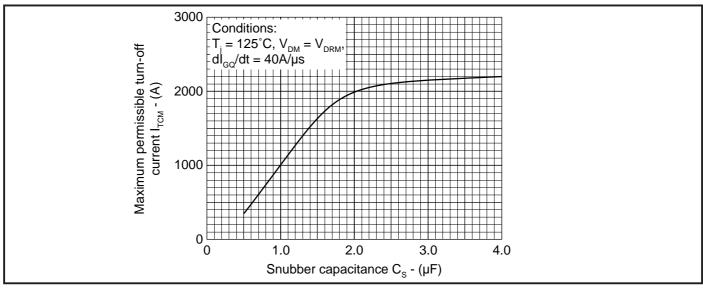
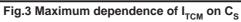
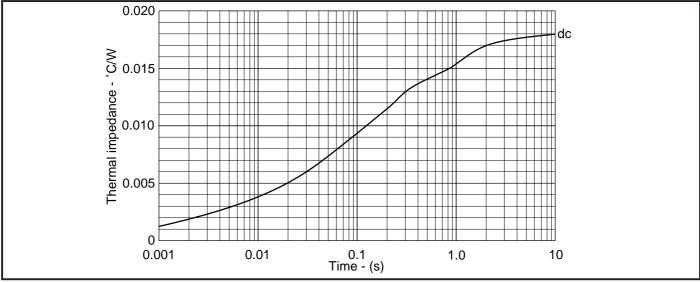


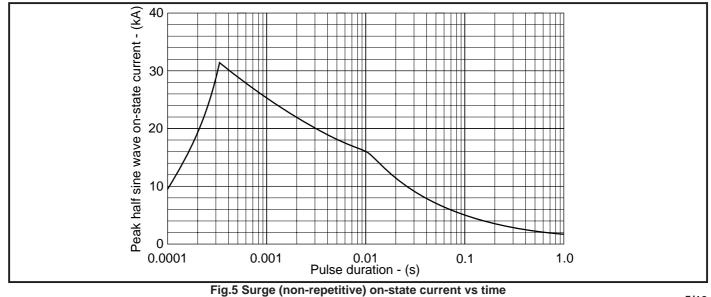
Fig.2 On-state characteristics











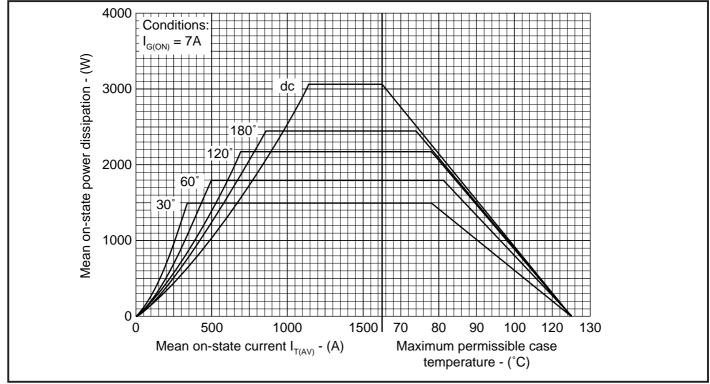


Fig.6 Steady state rectangluar wave conduction loss - double side cooled

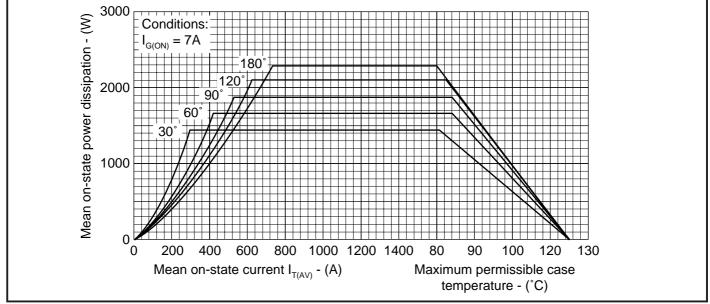


Fig.7 Steady state sinusoidal wave conduction loss - double side cooled

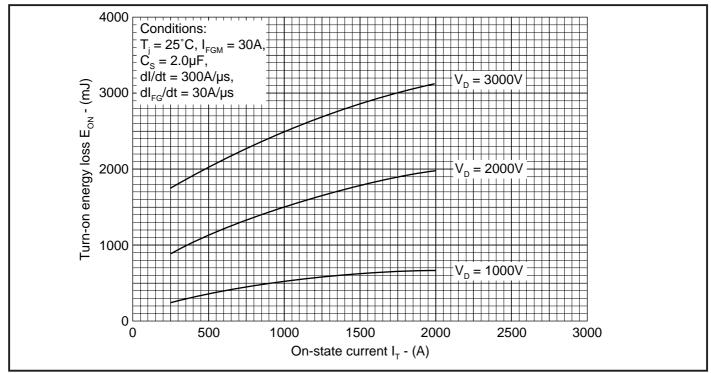


Fig.8 Turn-on energy vs on-state current

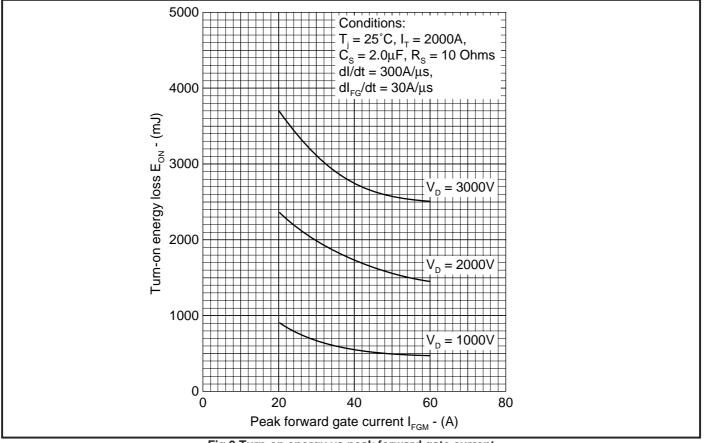
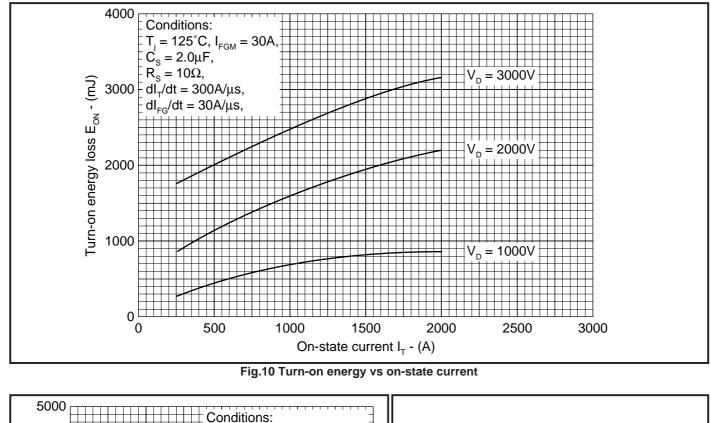
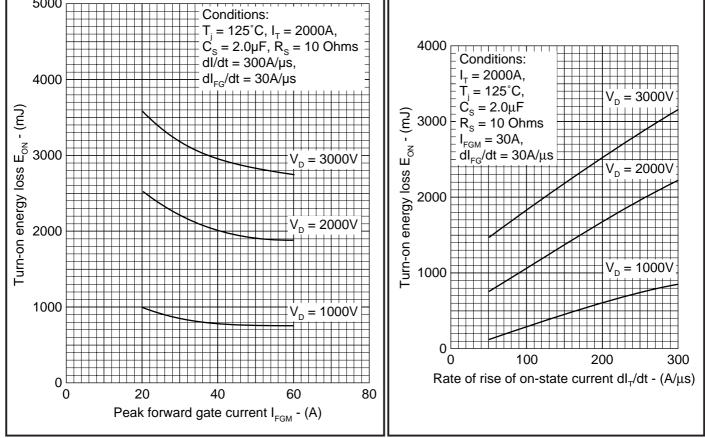


Fig.9 Turn-on energy vs peak forward gate current





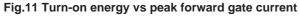


Fig.12 Turn-on energy vs rate of rise of on-state current

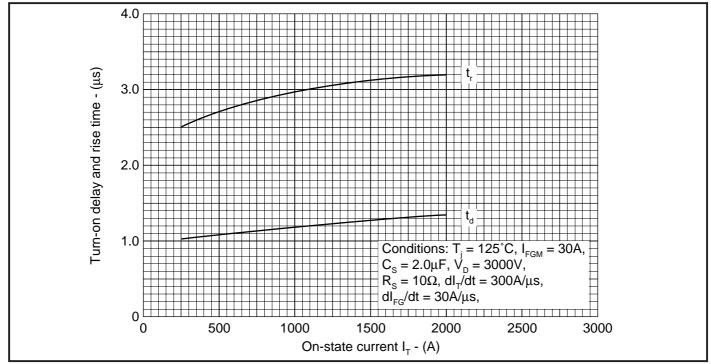
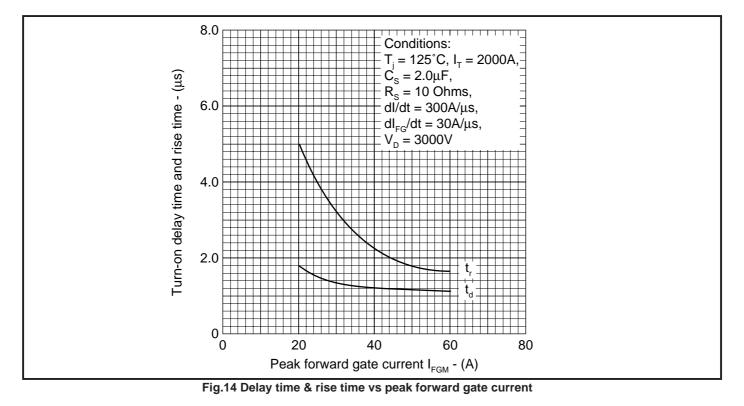


Fig.13 Delay time & rise time vs turn-on current



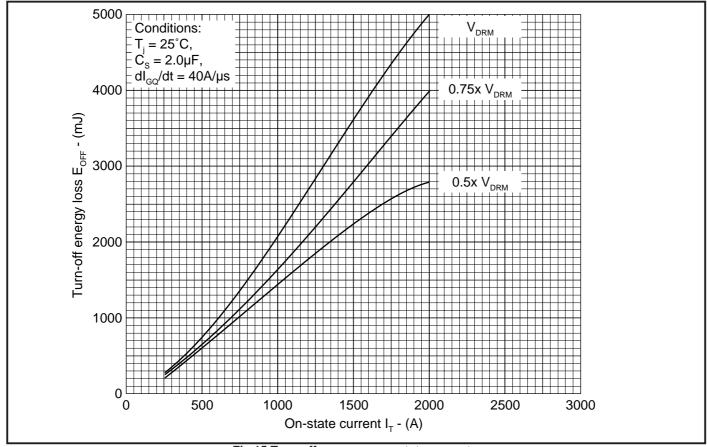


Fig.15 Turn-off energy vs on-state current

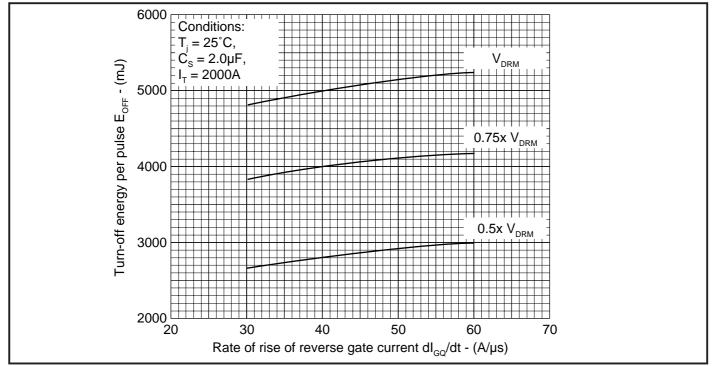


Fig.16 Turn-off energy vs rate of rise of reverse gate current

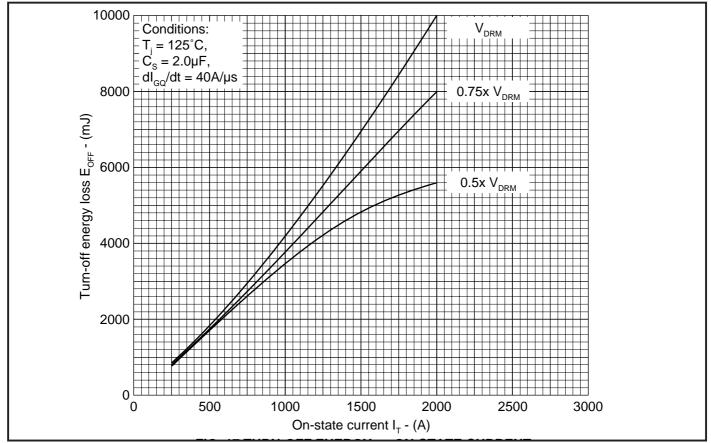


Fig.17 Turn-off energy vs on-state current

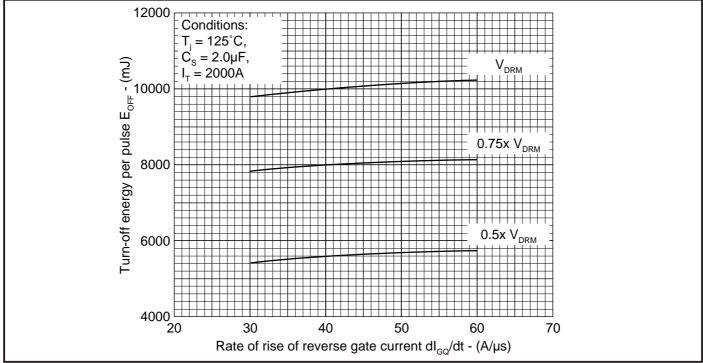
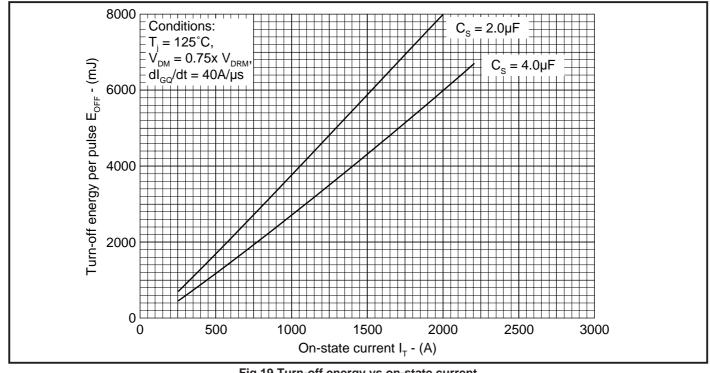
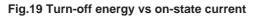


Fig.18 Turn-off energy loss vs rate of rise of reverse gate current





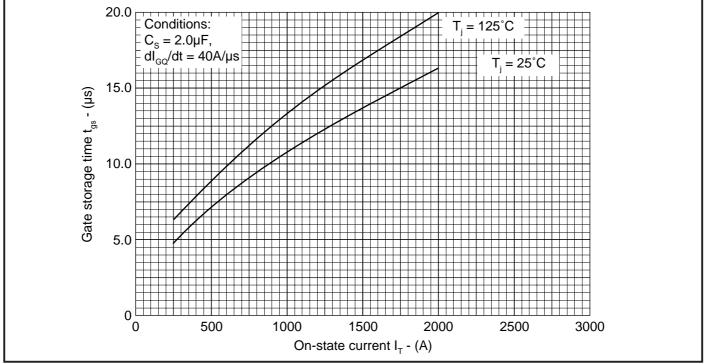
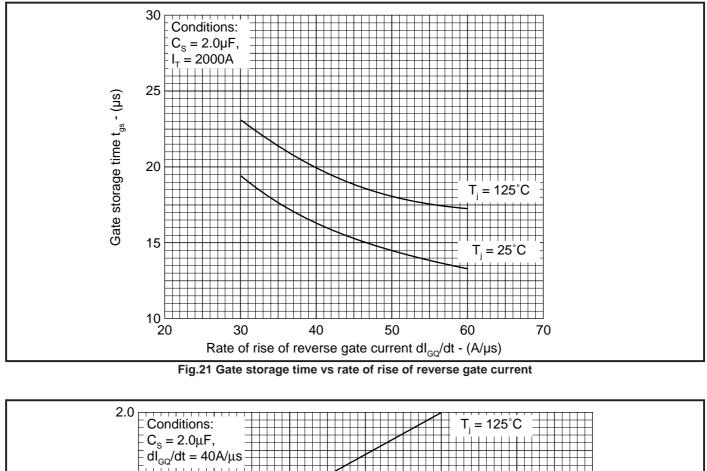


Fig.20 Gate storage time vs on-state current



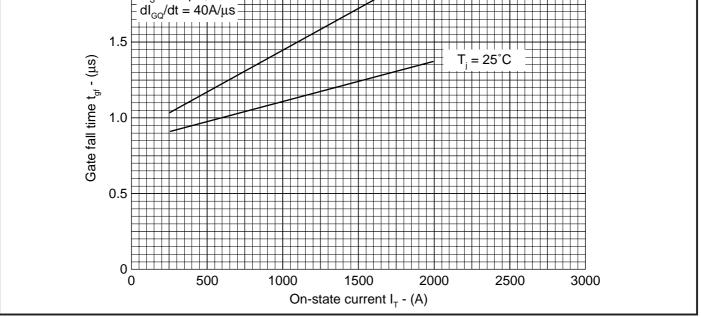


Fig.22 Gate fall time vs on-state current

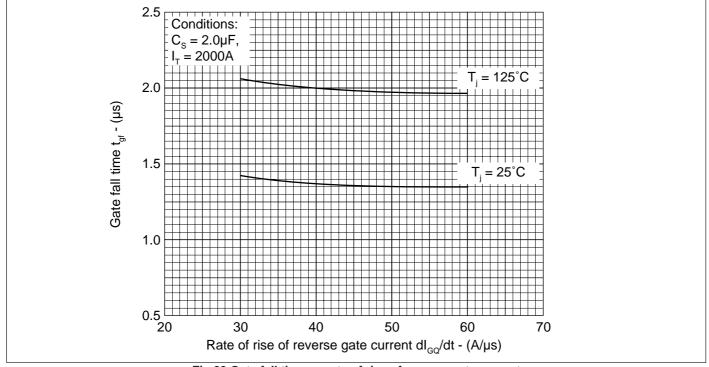


Fig.23 Gate fall time vs rate of rise of reverse gate current

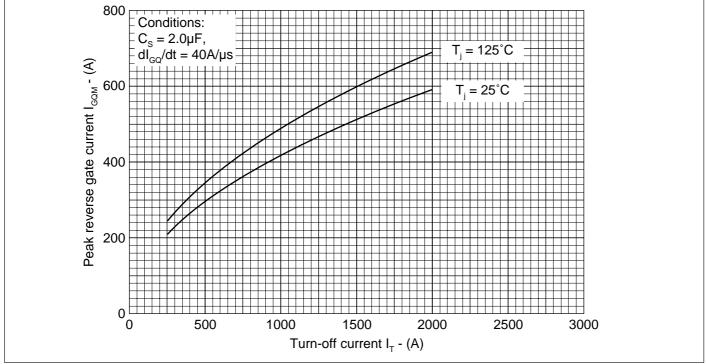


Fig.24 Peak reverse gate current vs turn-off current

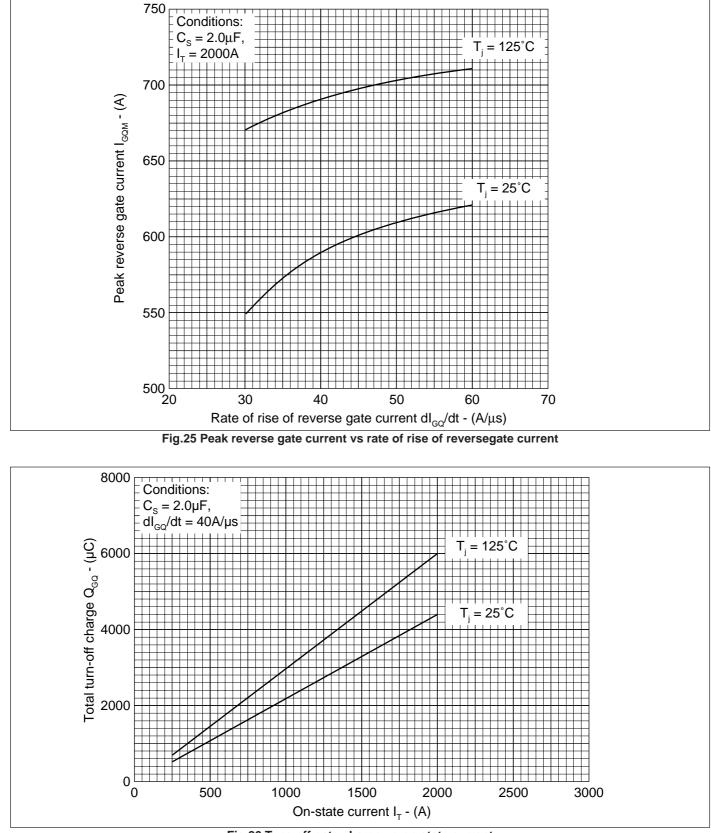


Fig.26 Turn-off gate charge vs on-state current

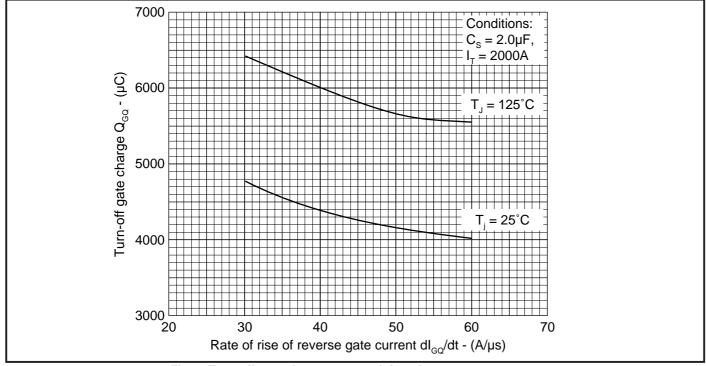


Fig.27 Turn-off gate charge vs rate of rise of reverse gate current

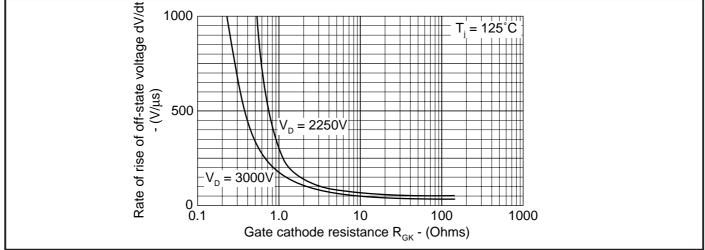


Fig.28 Rate of rise of off-state voltage vs gate cathode resistance

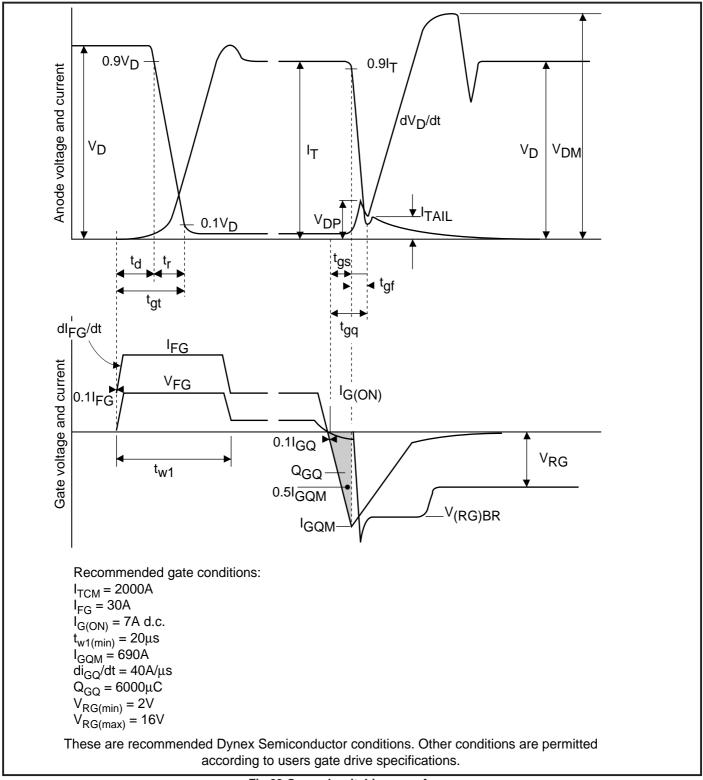
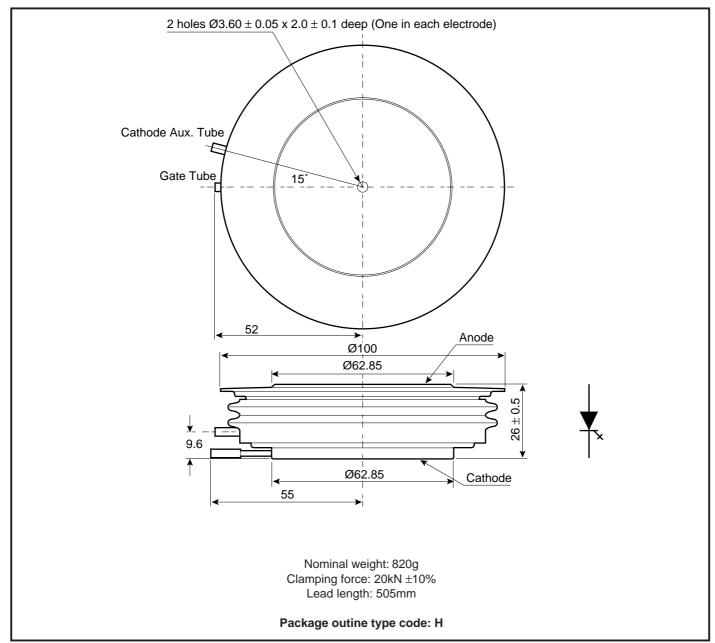


Fig.29 General switching waveforms

PACKAGE DETAILS

For further package information, please contact your local Customer Service Centre. All dimensions in mm, unless stated otherwise. DO NOT SCALE.



ASSOCIATED PUBLICATIONS

Title	Application Note	
	Number	
Calculating the junction temperature or power semiconductors	AN4506	
GTO gate drive units	AN4571	
Recommendations for clamping power semiconductors	AN4839	
Use of V_{TO} , r_{T} on-state characteristic	AN5001	
Impoved gate drive for GTO series connections	AN5177	

POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink / clamping systems in line with advances in device types and the voltage and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group continues to offer high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the up to date CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete solution (PACs).

DEVICE CLAMPS

Disc devices require the correct clamping force to ensure their safe operation. The PACs range offers a varied selection of preloaded clamps to suit all of our manufactured devices. This include cube clamps for single side cooling of 'T' 22mm

Clamps are available for single or double side cooling, with high insulation versions for high voltage assemblies.

Please refer to our application note on device clamping, AN4839

HEATSINKS

Power Assembly has it's own proprietary range of extruded aluminium heatsinks. They have been designed to optimise the performance or our semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest Sales Representative or the factory.



Datasheet Annotations:

Dynex Semiconductor annotate datasheets in the top right hard corner of the front page, to indicate product status. The annotations are as follows:-

Target Information: This is the most tentative form of information and represents a very preliminary specification. No actual design work on the product has been started.

Preliminary Information: The product is in design and development. The datasheet represents the product as it is understood but details may change.

Advance Information: The product design is complete and final characterisation for volume production is well in hand.

No Annotation: The product parameters are fixed and the product is available to datasheet specification

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